Vishay Siliconix

P-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-30			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -10 \text{ V}$	0.0055			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.0093			
Q _g typ. (nC)	36			
I _D (A)	-60 ^{a, g}			
Configuration	Single			

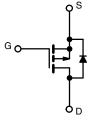
FEATURES

- TrenchFET® Gen III p-channel power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



APPLICATIONS

- · Adapter and charger switch
- · Load switch
- Battery management



P-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and halogen-free	SiR167DP-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	-30	V	
Gate-source voltage		V _{GS}	± 25	v	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-60 ^a		
	T _C = 70 °C	1 , —	-60 ^a		
	T _A = 25 °C	I _D	-23.8 b, c		
	T _A = 70 °C		-19.1 ^{b, c}		
Pulsed drain current (t = 100 μs)		I _{DM}	-120	A	
Continuous source-drain diode current	T _C = 25 °C		-54.8		
	T _A = 25 °C	Is Is	-4.2 ^{b, c}		
Single pulse avalanche current	1 0.1 ml l	I _{AS}	-20		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	20	mJ	
Maximum power dissipation	T _C = 25 °C		65.8		
	T _C = 70 °C		42.1	10/	
	T _A = 25 °C	P _D	5.1 ^{b, c}	W	
	T _A = 70 °C		3.2 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	%0	
Soldering recommendations (peak temperature) ^c			260	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient b	t ≤ 10 s	R _{thJA}	20	25	°C/W		
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.5	1.9	7 0/00		

Notes

- Package limited
 Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is 65 °C/W
- $T_C = 25 \, ^{\circ}C$



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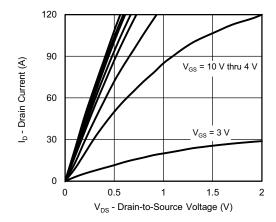
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	$I_D = -10 \text{ mA}$		-25.8	-	\//90	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	4.2	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-2.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	1	V _{DS} = -30 V, V _{GS} = 0 V	-	-	-1	μА	
	I _{DSS}	V _{DS} = -30 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-15		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α	
Drain-source on-state resistance ^a	_	V _{GS} = -10 V, I _D = -15 A	-	0.0046	0.0055	Ω	
	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$	-	0.0078	0.0093		
Forward transconductance ^a	9 _{fs}	V _{DS} = -15 V, I _D = -20 A	-	60	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	4380	-		
Output capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	535	-	pF	
Reverse transfer capacitance	C _{rss}		-	460	-		
Total gate above	0	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -23.8 \text{ A}$ $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -23.8 \text{ A}$	-	74	111	nC	
Total gate charge	Q_g		-	36	54		
Gate-source charge	Q _{gs}		-	12.1	-		
Gate-drain charge	Q_{gd}		-	12.3	-		
Gate resistance	Rg	f = 1 MHz	0.32	1.6	3.2	Ω	
Turn-on delay time	t _{d(on)}		-	20	40		
Rise time	t _r	V_{DD} = -15 V, R_L = 0.79 Ω , $I_D \cong$ -19.1 A, V_{GEN} = -10 V, R_g = 1 Ω	-	25	50		
Turn-off delay time	t _{d(off)}		-	35	70		
Fall time	t _f		-	18	36	1	
Turn-on delay time	t _{d(on)}		-	25	50	ns	
Rise time	t _r	$V_{DD} = -15 \text{ V}, R_L = 0.79 \Omega, I_D \cong -19.1 \text{ A},$	-	25	50		
Turn-off delay time	t _{d(off)}	V_{GEN} = -4.5 V, R_g = 1 Ω	-	35	70		
Fall time	t _f		-	22	44		
Drain-Source Body Diode Characterist	ics						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	-54.8	۸	
Pulse diode forward current	I _{SM}		-	-	-120	A	
Body diode voltage	V_{SD}	I _S = -5 A, V _{GS} = 0 V	-	-0.73	-1.2	V	
Body diode reverse recovery charge	Q _{rr}		-	45	90	nC	
Reverse recovery fall time	ta	I _F = -19.1 A, di/dt = 100 A/μs,	-	19	-		
Reverse recovery rise time	t _b	T _J = 25 °C	-	22	-	ns	

Notes

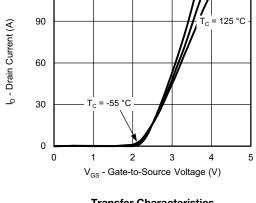
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





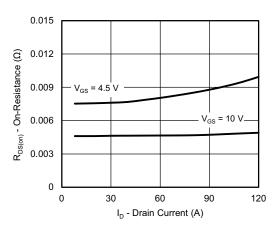
Output Characteristics



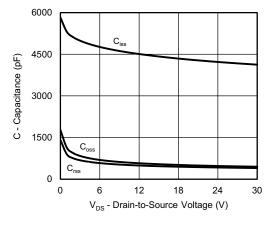
T_C = 25 °C

120

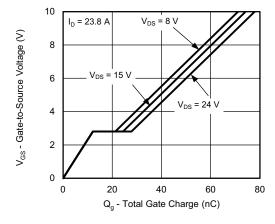
Transfer Characteristics



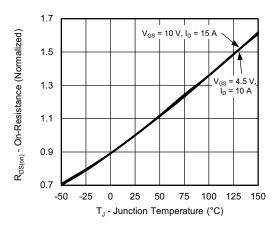
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

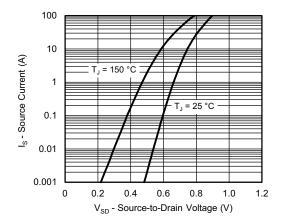




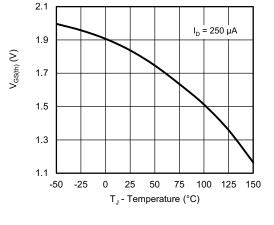


On-Resistance vs. Junction Temperature

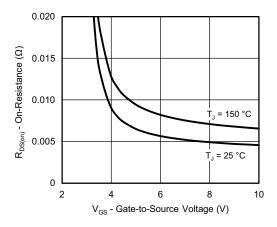




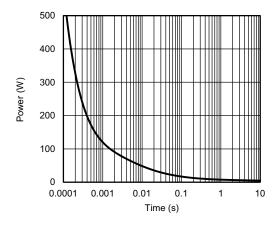
Source-Drain Diode Forward Voltage



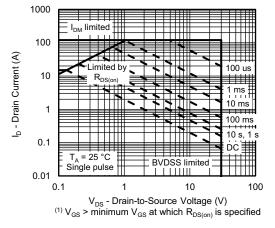
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

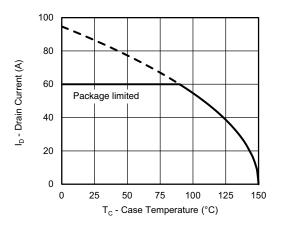


Single Pulse Power, Junction-to-Ambient

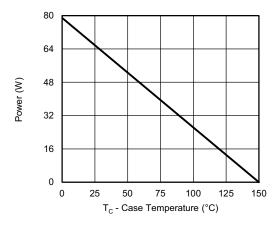


Safe Operating Area, Junction-to-Ambient

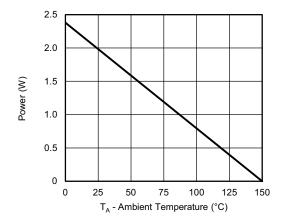




Current Derating a





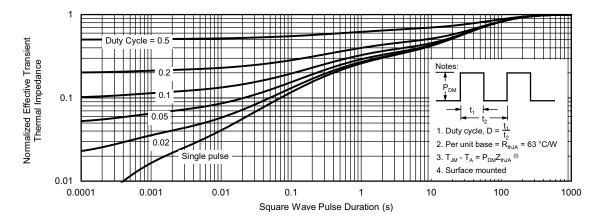


Power, Junction-to-Ambient

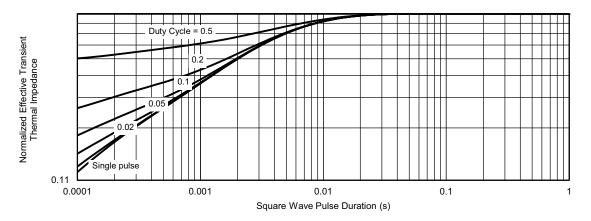
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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